

# TEST REPORT

Applicant Name : Xiamen VBET Electronic Co., Ltd.  
 Address : N403, Weiye Building, Xiamen Pioneering Park for Overseas Chinese Scholars, PRC  
 Report Number : SZ1220505-18164E-EM  
 FCC ID: 2AC67-8200

**Test Standard (s)**  
 FCC PART 15 Subpart B

**Sample Description**

Product Type: 8200 UC Headset  
 Model No.: VT 8200 Duo, VT 8200, VT 8200 Mono, 8200 Duo, 8200, 8200 Mono, VT 8200 USB, 8200 USB, VT 8208, VT 8208 Duo, 8208 Duo, VT 8208 Mono, 8208 Mono, 8208  
 Trade Mark: VT  
 Date Received: 2022-05-05  
 Date of Test: 2022-05-26  
 Report Date: 2022-05-27

Test Result:	Pass*
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\* In the configuration tested, the EUT complied with the standards above.

**Prepared and Checked By:**

**Approved By:**




Ting Lü  
 EMC Engineer

Candy Li  
 EMC Engineer

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## Test Report Declaration

Applicant : Xiamen VBeT Electronic Co., Ltd.  
Manufacturer : Xiamen VBeT Electronic Co., Ltd.  
Product : 8200 UC Headset  
Model No. : VT8200 Duo, VT 8200, VT 8200 Mono, 8200 Duo, 8200,  
8200 Mono, VT 8200 USB, 8200 USB, VT 8208,  
VT 8208 Duo, 8208 Duo, VT 8208 Mono, 8208 Mono, 8208  
Trade Mark : VT

Measurement Procedure Used:

### **FCC Rules and Regulations Part 15 Subpart B**

### **ANSI C63.4-2014**

The device described above is tested by Shenzhen Accurate Technology Co., Ltd. to determine the maximum emission levels emanating from the device. The maximum emission levels are compared to the FCC Part 15 Subpart B (Class B) limits both radiated and conducted emissions. The measurement results are contained in this test report and Shenzhen Accurate Technology Co., Ltd. is assumed full responsibility for the accuracy and completeness of these measurements. Also, this report shows that the Equipment Under Test (EUT) is to be technically compliant with the FCC requirements.

This report applies to above tested sample only. This report shall not be reproduced in part without written approval of Shenzhen Accurate Technology Co., Ltd.

## 1. TEST RESULTS SUMMARY

Test Items	Test Standard	Test Results
Conducted Emission (150kHz-30MHz)	FCC PART 15 Subpart B, Clause 15.107	Pass
Radiated Emission (30-1000MHz)	FCC PART 15 Subpart B, Clause 15.109	Pass

## 2. GENERAL INFORMATION

### 2.1. Description of Device (EUT)

Product	: 8200 UC Headset
Test Model No.	: VT 8200 Duo
Multiple Model	VT 8200, VT 8200 Mono, 8200 Duo, 8200, 8200 Mono, VT 8200 USB, 8200 USB, VT 8208, VT 8208 Duo, 8208 Duo, VT 8208 Mono, 8208 Mono, 8208
Model difference	Please refer to DOS letter.
Rating	: DC 5.0V (The earphone cable length is 2.33m.)
Remark(s)	: The EUT highest operating frequency is below 108MHz, the radiated emission measurement was made up to 1GHz
Applicant	: Xiamen VBeT Electronic Co., Ltd.
Address	: N403, Weiye Building, Xiamen Pioneering Park for Overseas Chinese Scholars, PRC
Manufacturer	: Xiamen VBeT Electronic Co., Ltd.
Address	: N403, Weiye Building, Xiamen Pioneering Park for Overseas Chinese Scholars, PRC
Sample Number	: SZ1220505-18164E-EM-S1 (VT 8200 Mono) SZ1220505-18164E-EM-S2 (VT 8200 Duo)

### 2.2. Test mode

Test mode: Playing

### 2.3. General disclaimer

1. Each test item follows test standard and with no deviation.
2. The test results presented in this report relate only to the object tested. The information supplied by the customer can affect the validity of results.

## 2.4. Accessory and Auxiliary Equipment and Cables

Notebook	:	Manufacturer: Lenovo Model number: T430
Adapter	:	Manufacturer: Lenovo Model number: 42T4416 Rating: 100-240V~50/60Hz, 1.5A Cable: AC 1.5m, DC 1.8m
Mouse	:	Manufacturer: DELL Model number: MOC5UG USB Cable: 1.5m
Keyboard	:	Manufacturer: DELL Model number: L100 USB Cable: 1.5m
Router	:	Manufacturer: HUAWEI Model number: WS5100
U-Disk	:	Manufacturer: SanDisk Model number: BN2105000737Z Storage Capacity: 64GB
Network Cable	:	5.0m

## 2.5. Description of Test Facility

Name of Firm	:	Shenzhen Accurate Technology Co., Ltd.
Site Location	:	1/F., Building A, Changyuan New Material Port, Science & Industry Park, Nanshan District, Shenzhen, Guangdong, P.R. China

## 2.6. Measurement Uncertainty

Radiated emission expanded uncertainty (30MHz-1000MHz)	:	$U=4.28dB, k=2$
Conduction Emission Expanded Uncertainty (150kHz-30MHz)	:	$U=2.72dB, k=2$

### 3. MEASURING DEVICE AND TEST EQUIPMENT

#### 3.1. For Conducted Emission Test

Item	Manufacturer	Equipment	Model No.	Serial No.	Calibration Date	Calibration Due Date
1.	Rohde & Schwarz	EMI Test Receiver	ESCI	100784	2021/12/13	2022/12/12
2.	Rohde & Schwarz	L.I.S.N.	ENV216	101314	2021/12/13	2022/12/12
3.	Anritsu Corp	50 Coaxial Switch	MP59B	6100237248	2021/12/13	2022/12/12
4.	Unknown	RF Coaxial Cable	No.17	N0350	2021/12/14	2022/12/13
5.	Conducted Emission Test Software: e3 19821b (V9)					

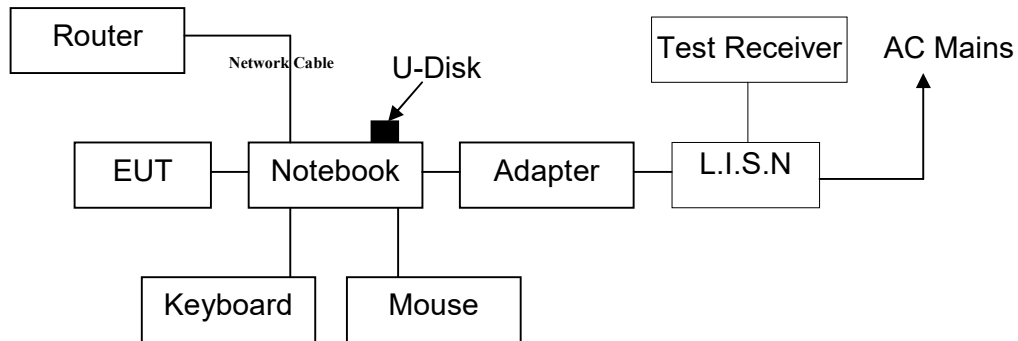
#### 3.2. For Radiated Emission Measurement

Item	Manufacturer	Equipment	Model No.	Serial No.	Calibration Date	Calibration Due Date
1.	Rohde & Schwarz	Test Receiver	ESR	102725	2021/12/13	2022/12/12
2.	SONOMA INSTRUMENT	Amplifier	310 N	186131	2021/11/09	2022/11/08
3.	Schwarzbeck	Bilog Antenna	VULB9163	9163-323	2021/07/06	2024/07/05
4.	Unknown	RF Coaxial Cable	No.12	N040	2021/12/14	2022/12/13
5.	Unknown	RF Coaxial Cable	No.13	N300	2021/12/14	2022/12/13
6.	Unknown	RF Coaxial Cable	No.14	N800	2021/12/14	2022/12/13
7.	Radiated Emission Test Software: e3 19821b (V9)					

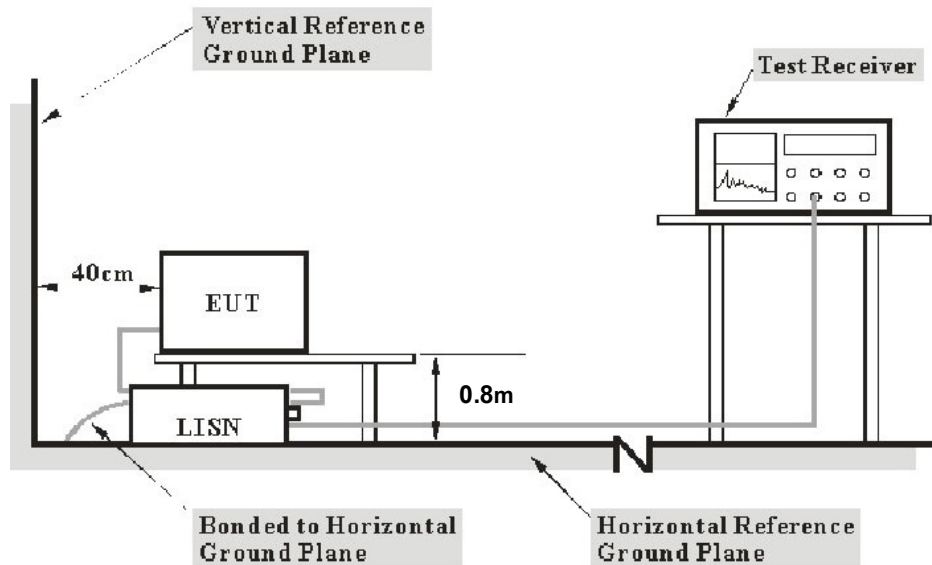
## 4. CONDUCTED EMISSION MEASUREMENT

### 4.1. Block Diagram of Test Setup

#### 4.1.1. Block diagram of connection between the EUT and simulators



#### 4.1.2. Test System Setup



- Note: 1. Support units were connected to second LISN.  
 2. Both of LISNs (AMN) 80 cm from EUT and at the least 0.8m from other units and other metal planes support units.



## 4.2. Power Line Conducted Emission Measurement Limits (Class B)

Frequency (MHz)	Limit dB( $\mu$ V)	
	Quasi-peak Level	Average Level
0.15 - 0.50	66.0 – 56.0 *	56.0 – 46.0 *
0.50 - 5.00	56.0	46.0
5.00 - 30.00	60.0	50.0

NOTE1: The lower limit shall apply at the transition frequencies.  
NOTE2: The limit decreases linearly with the logarithm of the frequency in the range 0.15MHz to 0.50MHz.

## 4.3. Test mode description

Test mode: Playing

### 4.3.1. Environmental Conditions

Temperature : 23 °C  
Relative Humidity : 50 %  
ATM Pressure : 101.1 kPa

The testing was performed by Jason Liu on 2022-05-26.

## 4.4. Manufacturer

The following equipments are installed on Power Line Conducted Emission Measurement to meet the commission requirement and operating regulations in a manner, which tends to maximize its emission characteristics in a normal application.

### 4.4.1. 8200 UC Headset (EUT)

Model Number : VT 8200 Duo  
Manufacturer : Xiamen VBeT Electronic Co., Ltd.

## 4.5. Operating Condition of EUT

4.5.1. Setup the EUT and simulator as shown as Section 4.1.

4.5.2. Turn on the power of all equipments.

4.5.3. Let the EUT work in test mode and measure it.

#### 4.6. Test Procedure

The EUT is put on the plane 0.8m high above the ground by insulating support and is connected to the power mains through a line impedance stabilization network (L.I.S.N.). This provides a 50ohm coupling impedance for the EUT system. Please refer the block diagram of the test setup and photographs. Both sides of AC lines are checked to find out the maximum conducted emission. In order to find the maximum emission levels, the relative positions of equipment and all of the interface cables shall be changed according to ANSI C63.4-2014 on Conducted Emission Measurement.

The bandwidth of test receiver is set at 9kHz.

The frequency range from 150kHz to 30MHz is checked.

#### 4.7. Data Explain

Over limit = Level (dB $\mu$ V) - Limit (dB $\mu$ V)

#### 4.8. Power Line Conducted Emission Measurement Results

**PASS.**

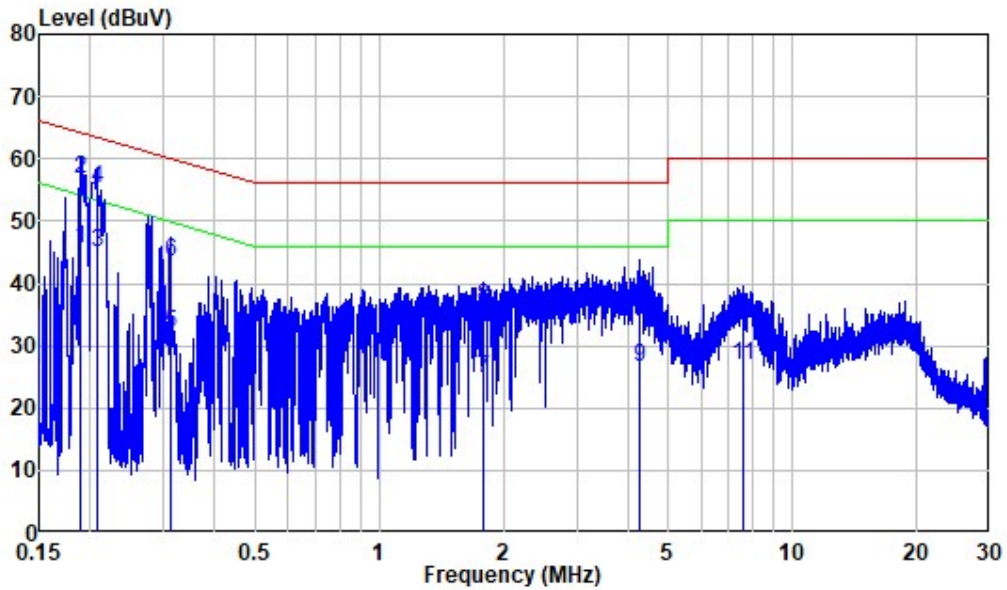
The frequency range from 150kHz to 30MHz is checked.

Maximizing procedure was performed on the six (6) highest emissions of the EUT. Emissions attenuated more than 20 dB below the permissible value are not reported.

All data was recorded in the Quasi-peak and average detection mode.

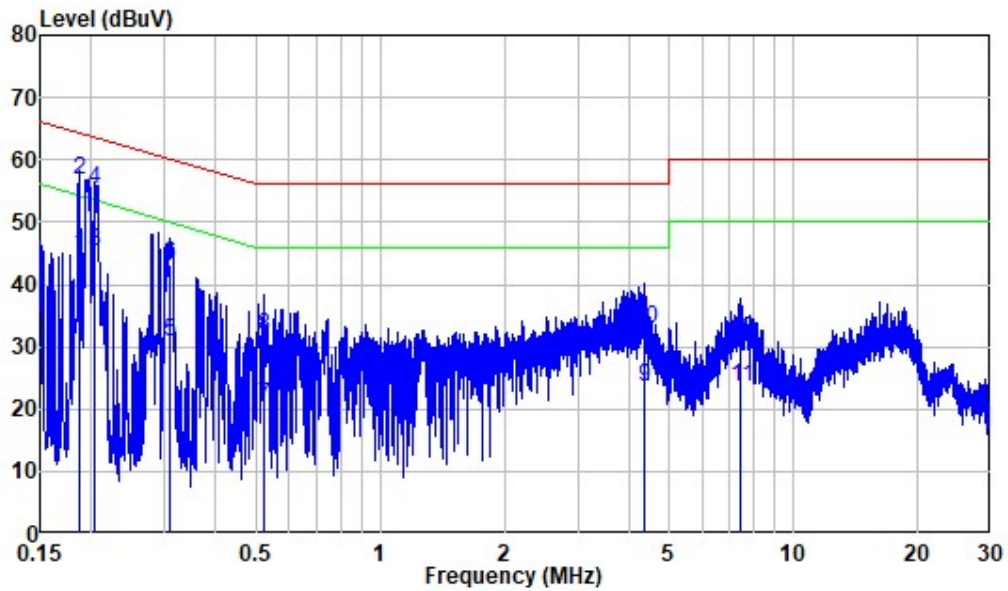
The spectral diagrams are attached as below.

The VT8200 Duo model was worst and recorded:



Site : Shielding Room  
 Condition: Line  
 Job No. : SZ1220505-18164E-EM  
 Mode : Playing  
 Power : AC 120V 60Hz

	Freq	Factor	Read Level	Level	Limit Line	Over Limit	Remark
	MHz	dB	dBuV	dBuV	dBuV	dB	
1	0.190	9.80	35.90	45.70	54.05	-8.35	Average
2	0.190	9.80	46.93	56.73	64.05	-7.32	QP
3	0.207	9.80	35.12	44.92	53.33	-8.41	Average
4	0.207	9.80	45.43	55.23	63.33	-8.10	QP
5	0.312	9.80	22.34	32.14	49.92	-17.78	Average
6	0.312	9.80	33.78	43.58	59.92	-16.34	QP
7	1.790	9.82	14.94	24.76	46.00	-21.24	Average
8	1.790	9.82	26.51	36.33	56.00	-19.67	QP
9	4.272	9.84	16.87	26.71	46.00	-19.29	Average
10	4.272	9.84	26.26	36.10	56.00	-19.90	QP
11	7.551	9.88	16.89	26.77	50.00	-23.23	Average
12	7.551	9.88	23.53	33.41	60.00	-26.59	QP



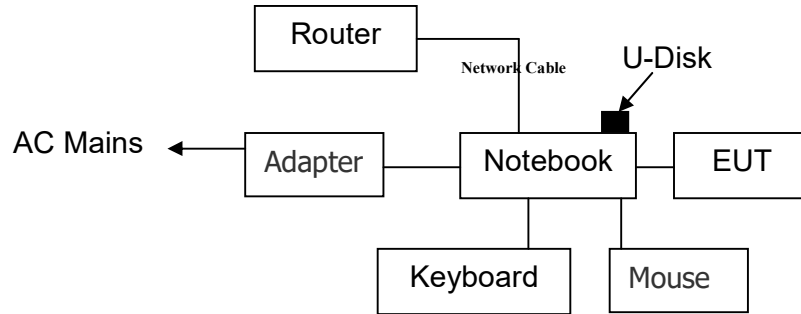
Site : Shielding Room  
 Condition: Neutral  
 Job No. : SZ1220505-18164E-EM  
 Mode : Playing  
 Power : AC 120V 60Hz

	Freq	Factor	Read Level	Level	Limit Line	Over Limit	Remark
	MHz	dB	dBuV	dBuV	dBuV	dB	
1	0.187	9.80	34.79	44.59	54.19	-9.60	Average
2	0.187	9.80	47.05	56.85	64.19	-7.34	QP
3	0.204	9.80	35.39	45.19	53.46	-8.27	Average
4	0.204	9.80	45.41	55.21	63.46	-8.25	QP
5	0.310	9.80	20.91	30.71	49.98	-19.27	Average
6	0.310	9.80	33.48	43.28	59.98	-16.70	QP
7	0.521	9.81	10.79	20.60	46.00	-25.40	Average
8	0.521	9.81	21.87	31.68	56.00	-24.32	QP
9	4.358	9.86	13.55	23.41	46.00	-22.59	Average
10	4.358	9.86	23.14	33.00	56.00	-23.00	QP
11	7.446	9.97	13.56	23.53	50.00	-26.47	Average
12	7.446	9.97	21.20	31.17	60.00	-28.83	QP

## 5. RADIATED EMISSION MEASUREMENT

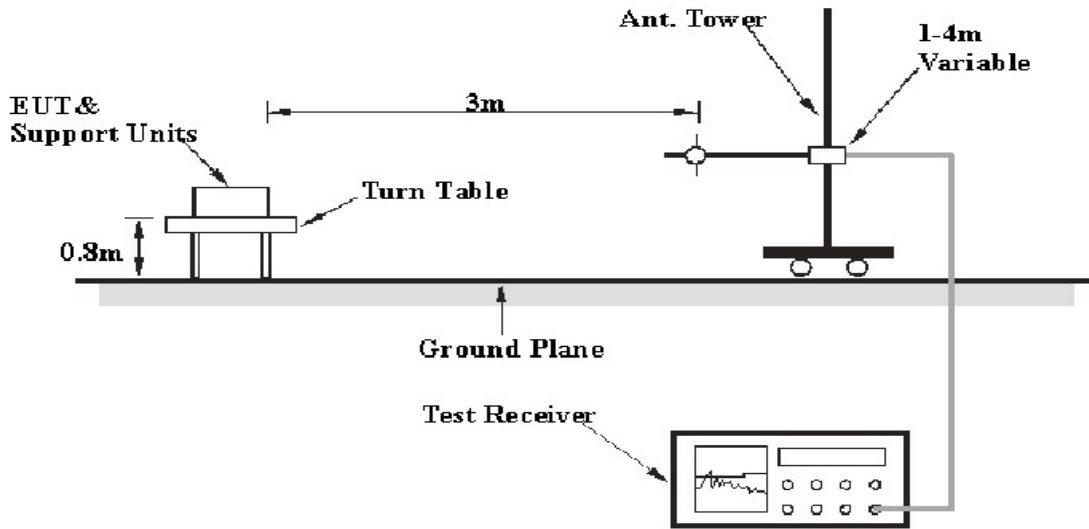
### 5.1. Block Diagram of Test Setup

#### 5.1.1. Block diagram of connection between the EUT and simulators



#### 5.1.2. Test System Setup

**Below 1GHz:**



## 5.2. Radiated Emission Limit (Class B)

All emanations from a class B device or system, including any network of conductors and apparatus connected thereto, shall not exceed the level of field strengths specified below:

Below 1GHz:

Frequency MHz	Distance Meters	Field Strengths Limit	
		$\mu\text{V/m}$	$\text{dB}(\mu\text{V/m})$
30-88	3	100	40.0
88-216	3	150	43.5
216-960	3	200	46.0
960-1000	3	500	54.0

Remark:

(1) Emission level  $\text{dB}(\mu\text{V}) = 20 \log$  Emission level  $\mu\text{V/m}$ .

(2) The smaller limit shall apply at the cross point between two frequency bands.

(3) Distance is the distance in meters between the measuring instrument antenna and the closest point of any part of the device or system.

## 5.3. Test mode description

Test mode: Playing

### 5.3.1. Environmental Conditions

Temperature : 23 °C

Relative Humidity : 50 %

ATM Pressure : 101.1 kPa

The testing was performed by Jason Liu on 2022-05-26.

## 5.4. Manufacturer

The following equipments are installed on Radiated Emission Measurement to meet the commission requirement and operating regulations in a manner, which tends to maximize its emission characteristics in a normal application.

### 5.4.1. 8200 UC Headset (EUT)

Model Number : VT 8200 Duo, VT 8200 Mono

Manufacturer : Xiamen VBeT Electronic Co., Ltd.

## 5.5. Operating Condition of EUT

5.5.1. Setup the EUT and simulator as shown as Section 5.1.

5.5.2. Turn on the power of all equipments.

5.5.3. Let the EUT work in test mode and measure it.

## 5.6. Test Procedure

The EUT and its simulators are placed on a turntable, which is 0.8m high above ground. The turntable can rotate 360 degrees to determine the position of the maximum emission level. EUT is set 3.0 meters away from the receiving antenna, which is mounted on an antenna tower. The antenna can be moved up and down between 1.0 meter and 4 meters to find out the maximum emission level. Broadband antenna (calibrated bilog antenna) is used as receiving antenna. Both horizontal and vertical polarizations of the antenna are set on measurement. In order to find the maximum emission levels, all of the interface cables must be manipulated according to ANSI C63.4-2014 on radiated emission measurement.

The bandwidth is set at 9kHz in 9kHz-30MHz, 120 kHz in 30-1000MHz, and 1MHz for above 1GHz.

The frequency range from 30MHz to 1GHz is investigated.

Highest frequency generated or used in the device or on which the device operates or tunes (MHz)	Upper frequency of measurement range (MHz)
Below 1.705 .....	30.
1.705–108 .....	1000.
108–500 .....	2000.
500–1000 .....	5000.
Above 1000 .....	5th harmonic of the highest frequency or 40 GHz, whichever is lower.

## 5.7. Data Sample

Over Limit (dB) = Level(dB $\mu$ v/m) - Limit (dB $\mu$ v/m)

QP = Quasi-peak Reading

The “Over Limit” column of the following data tables indicates the degree of compliance with the applicable limit. For example, an over Limit of -7dB means the emission is 7dB below the limit.

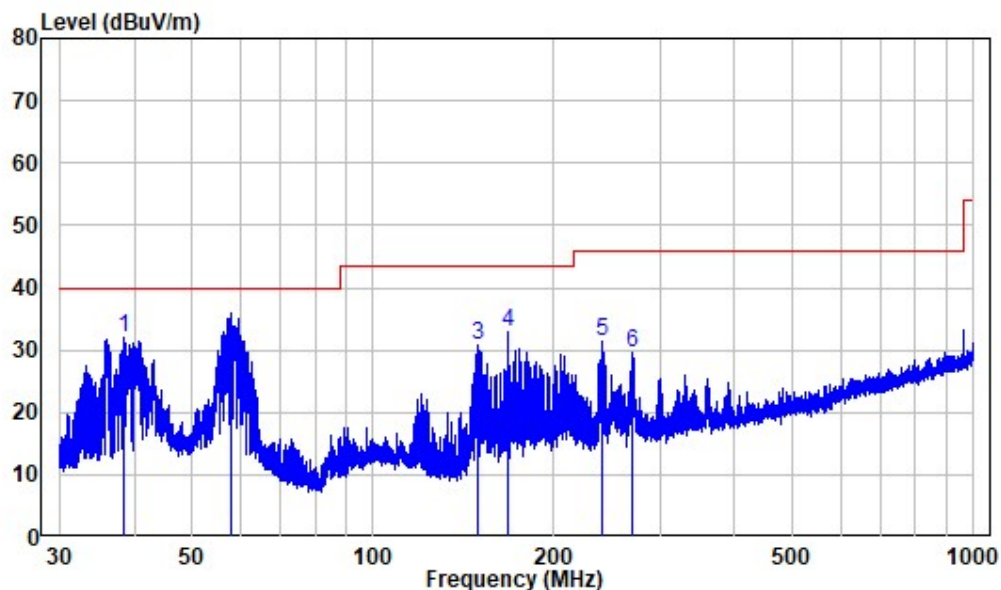
## 5.8.Radiated Emission Measurement Result

**PASS.**

The frequency range from 30MHz to 1GHz is investigated.

The spectral diagrams are attached as below.

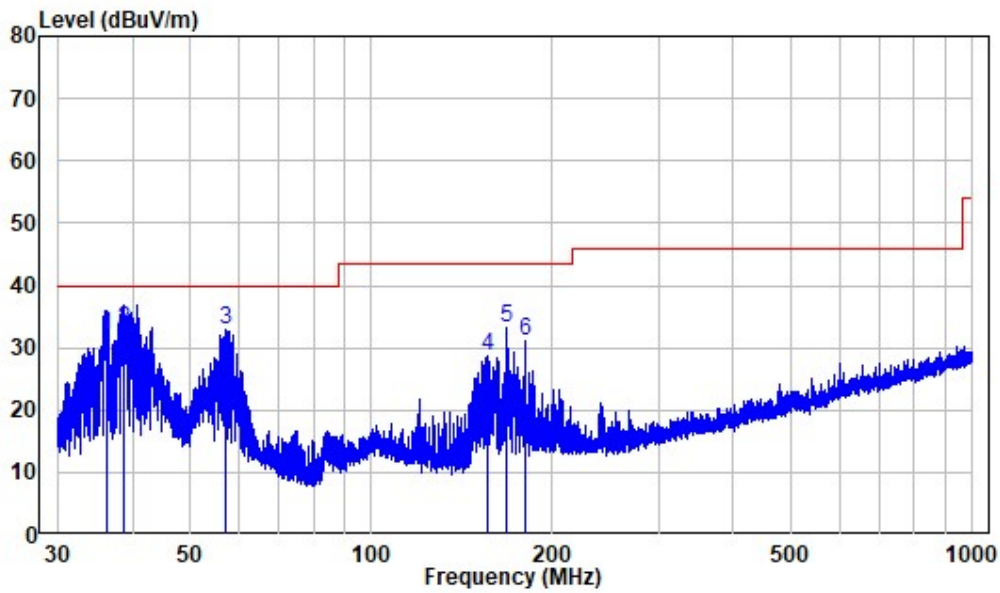
VT 8200 Mono:



Site : chamber  
 Condition: 3m HORIZONTAL  
 Job No. : SZ1220505-18164E-EM  
 Test Mode: Playing  
 Note : S1

	Freq	Factor	Read Level	Limit Level	Over Limit	Remark
	MHz	dB/m	dBuV	dBuV/m	dBuV/m	dB
1	38.565	-10.69	42.60	31.91	40.00	-8.09 Peak
2	58.127	-9.95	39.64	29.69	40.00	-10.31 QP
3	148.963	-15.33	46.07	30.74	43.50	-12.76 Peak
4	167.971	-13.78	46.67	32.89	43.50	-10.61 Peak
5	241.147	-10.83	42.28	31.45	46.00	-14.55 Peak
6	270.968	-10.17	39.68	29.51	46.00	-16.49 Peak

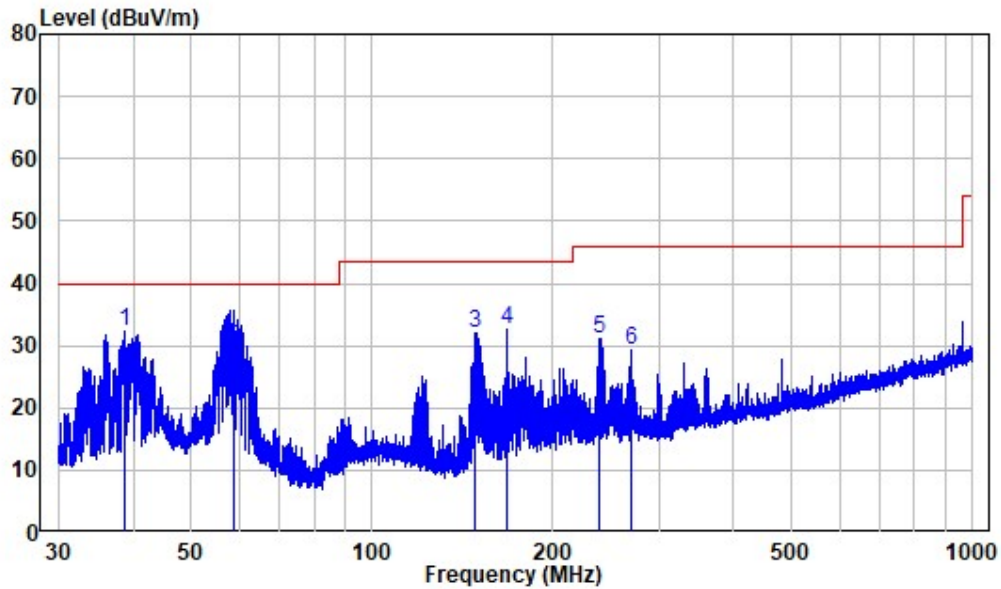




Site : chamber  
 Condition: 3m VERTICAL  
 Job No. : SZ1220505-18164E-EM  
 Test Mode: Playing  
 Note : S1

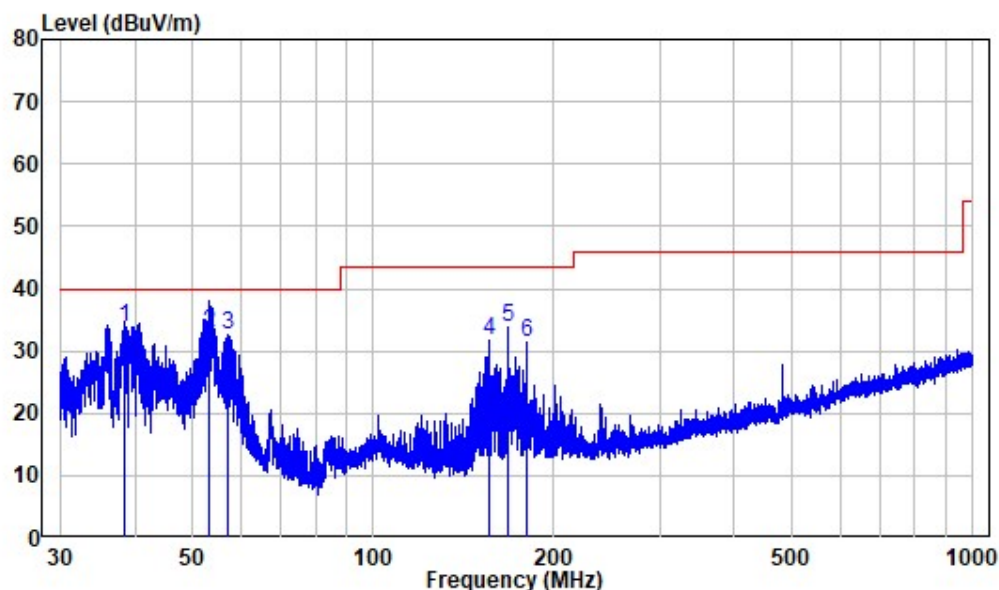
	Freq	Factor	Read Level	Level	Limit Line	Over Limit	Remark
	MHz	dB/m	dBuV	dBuV/m	dBuV/m	dB	
1	36.159	-11.17	43.16	31.99	40.00	-8.01	QP
2	38.633	-10.67	43.44	32.77	40.00	-7.23	QP
3	57.292	-10.01	42.96	32.95	40.00	-7.05	Peak
4	156.047	-14.81	43.63	28.82	43.50	-14.68	Peak
5	167.971	-13.78	46.90	33.12	43.50	-10.38	Peak
6	180.095	-12.76	43.91	31.15	43.50	-12.35	Peak

VT 8200 Duo



Site : chamber  
 Condition: 3m HORIZONTAL  
 Job No. : SZ1220505-18164E-EM  
 Test Mode: Playing  
 Note : S2

	Freq	Factor	Read Level	Level	Limit Line	Over Limit	Remark
	MHz	dB/m	dBuV	dBuV/m	dBuV/m	dB	
1	38.599	-10.68	42.91	32.23	40.00	-7.77	Peak
2	58.922	-10.24	39.75	29.51	40.00	-10.49	QP
3	148.832	-15.34	47.31	31.97	43.50	-11.53	Peak
4	167.898	-13.79	46.46	32.67	43.50	-10.83	Peak
5	239.672	-10.92	42.11	31.19	46.00	-14.81	Peak
6	270.020	-10.23	39.45	29.22	46.00	-16.78	Peak



Site : chamber  
 Condition: 3m VERTICAL  
 Job No. : SZ1220505-18164E-EM  
 Test Mode: Playing  
 Note : S2

	Read	Limit	Over		
Freq	Factor	Level	Level	Line	Limit Remark
MHz	dB/m	dBuV	dBuV/m	dBuV/m	dB
1	38.430	-10.71	44.39	33.68	40.00 -6.32 QP
2	53.131	-10.19	43.11	32.92	40.00 -7.08 QP
3	57.317	-10.01	42.68	32.67	40.00 -7.33 Peak
4	155.979	-14.82	46.44	31.62	43.50 -11.88 Peak
5	167.898	-13.79	47.55	33.76	43.50 -9.74 Peak
6	179.938	-12.78	44.30	31.52	43.50 -11.98 Peak

Note 1:

Factor = Antenna factor (RX) + Cable Loss – Amplifier Factor

The other spurious emission which is in the noise floor level was not recorded.

Note 2: If the maximized peak measured value complies with the limit, then it is unnecessary to perform QP/Average measurement.

----- THE END OF TEST REPORT -----